

**Notice of References Cited**

Application/Control No.

10/648,611

Applicant(s)/Patent Under

Reexamination

SMITH ET AL.

Examiner

Tam M. Nguyen

Art Unit

1764

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0125599 A1	07-2003	Boudreau et al.	585/809
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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